

Notice of References Cited	Application/Control No. 10/567,117		Applicant(s)/Patent Under Reexamination FUJIWARA ET AL.	
	Examiner JOHN S. CHU		Art Unit 1795	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0202954 A1	10-2004	Momota et al.	430/170
*	B	US-2004/0176630 A1	09-2004	Watanabe et al.	558/430
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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